

<b>Notice of References Cited</b>	Application/Control No. 10/563,824	Applicant(s)/Patent Under Reexamination TSUCHIYA ET AL.	
	Examiner Christian A. Hannon	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,039,443	05-2006	Opela et al.	455/565
*	B	US-2003/0162530	08-2003	Morota et al.	455/414
*	C	US-6,944,481	09-2005	Hama et al.	455/566
*	D	US-6,434,371	08-2002	Claxton, Daniel	455/90.1
*	E	US-6,567,672	05-2003	Park et al.	455/574
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.